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А	Update document paragraphs to current requirements ro	17-04-20	C. SAFFLE								



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		SIZE A	COD	E IDE	NT. N	o. 236			DWG	G NO.		\	/62	/11	61	1			
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AMSC N/A 5962-V041-17

1. SCOPE

- 1.1 <u>Scope</u>. This drawing documents the general requirements of a high performance 12 bit analog to digital converter microcircuit, with an operating temperature range of -55°C to +125°C.
- 1.2 <u>Vendor Item Drawing Administrative Control Number</u>. The manufacturer's PIN is the item of identification. The vendor item drawing establishes an administrative control number for identifying the item on the engineering documentation:

 V6211611
 01
 X
 E

 Drawing number
 Device type (See 1.2.1)
 Case outline (See 1.2.2)
 Lead finish (See 1.2.3)

1.2.1 Device type(s).

Device typeGenericCircuit function01AD7476-EP12 bit analog to digital converter

1.2.2 <u>Case outline(s)</u>. The case outline(s) are as specified herein.

 Outline letter
 Number of pins
 JEDEC PUB 95
 Package style

 X
 6
 MO-178-AB
 Plastic small outline surface mount

1.2.3 <u>Lead finishes</u>. The lead finishes are as specified below or other lead finishes as provided by the device manufacturer:

Finish designator

A Hot solder dip
B Tin-lead plate
C Gold plate
D Palladium
E Gold flash palladium
Z Other

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1.3 Absolute maximum ratings. 1/

Supply voltage (VDD) to ground (GND) Analog input voltage to GND Digital input voltage to GND Digital output voltage to GND	0.3 V to VDD + 0.3 V 0.3 V to 7 V 0.3 V to VDD + 0.3 V
Input current to any pin except supplies Junction temperature range (TJ)	-
Storage temperature range (TSTG)	235°C 255°C
Thermal resistance, junction to ambient (θ JC)	92°C/W
Thermal resistance, junction to ambient (θ JA)	230°C/W
1.4 Recommended operating conditions. 3/4/	
Supply voltage (VDD) range Operating free-air temperature range (T _A)	

^{4/} All ratings and specifications, please refer to the relevant EP datasheet.

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Stresses beyond those listed under "absolute maximum rating" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

^{2/} Transient currents of up to 100 mA do not cause silicon controlled rectifier (SCR) latch up.

Use of this product beyond the manufacturers design rules or stated parameters is done at the user's risk. The manufacturer and/or distributor maintain no responsibility or liability for product used beyond the stated limits.

2. APPLICABLE DOCUMENTS

JEDEC Solid State Technology Association

JEDEC PUB 95 - Registered and Standard Outlines for Semiconductor Devices

(Copies of these documents are available online at http://www.jedec.org or from JEDEC – Solid State Technology Association, 3103 North 10th Street, Suite 240–S, Arlington, VA 22201-2107).

3. REQUIREMENTS

- 3.1 <u>Marking</u>. Parts shall be permanently and legibly marked with the manufacturer's part number as shown in 6.3 herein and as follows:
 - A. Manufacturer's name, CAGE code, or logo
 - B. Pin 1 identifier
 - C. ESDS identification (optional)
- 3.2 <u>Unit container</u>. The unit container shall be marked with the manufacturer's part number and with items A and C (if applicable) above.
- 3.3 <u>Electrical characteristics</u>. The maximum and recommended operating conditions and electrical performance characteristics are as specified in 1.3, 1.4, and table I herein.
 - 3.4 Design, construction, and physical dimension. The design, construction, and physical dimensions are as specified herein.
 - 3.5 Diagrams.
 - 3.5.1 Case outline. The case outline shall be as shown in 1.2.2 and figure 1.
 - 3.5.2 Terminal connections. The terminal connections shall be as shown in figure 2.
- 3.5.3 <u>Load circuit for digital output timing specifications</u>. The load circuit for digital output timing specifications shall be as shown in figure 3.

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TABLE I. Electrical performance characteristics. 1/

Test	Symbol	Conditions <u>2</u> /	Temperature, TA	Device type	Lir	nits	Unit		
					Min	Max]		
Dynamic performance se	ection.	f _{IN} = 100 kHz sine wave							
Signal to (noise +	SINAD		+25°C	01	70		dB		
distortion)			-55°C to +125°C		69		1		
Signal to noise ratio	SNR		-55°C to +125°C	01	70		dB		
Total harmonic distortion	THD		-55°C to +125°C	01	-78 t	ypical	dB		
Peak harmonic or spurious noise	SFDR		-55°C to +125°C	01	-80 typical		dB		
Intermodulation distortion, second order terms	IMD	fa = 103.5 kHz, fb = 113.5 kHz	-55°C to +125°C	01	01 -78 typ		dB		
Intermodulation distortion, third order terms	IMD	fa = 103.5 kHz, fb = 113.5 kHz	-55°C to +125°C	01	01 -78 typi		-78 typical		dB
Aperture delay			-55°C to +125°C	01	10 ty	/pical	ns		
Aperture jitter			-55°C to +125°C	01	30 ty	/pical	ps		
Full power bandwidth	FPBW	At 3 dB	-55°C to +125°C	01	6.5 t	ypical	MHz		
DC accuracy section.		VDD = 2.35 V to 3.6 V <u>3</u> /							
Resolution			-55°C to +125°C	01	12		Bits		
Integral nonlinearity	INL		+25°C	01	±0.6	typical	LSB		
			-55°C to +125°C			±1.5	1		
Differential nonlinearity	DNL	Guaranteed in missed codes to	+25°C	01	±0.75	typical	LSB		
		12 bits	-55°C to +125°C		-0.9	+1.5	1		
Offset error	OE		-55°C to +125°C	01		±2	LSB		
Gain error	GE		-55°C to +125°C	01		±2	LSB		
Analog input section.			<u> </u>			•	•		
Input voltage ranges	VIN		-55°C to +125°C	01	0 to V _{DD}		V		
DC leakage current			-55°C to +125°C	01		±1	μА		
Input capacitance	CIN		-55°C to +125°C	01	30 ty	/pical	pF		

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TABLE I. Electrical performance characteristics - continued. $\underline{1}/$

Test	Symbol	Conditions <u>2</u> /	Temperature,	Device type	Lir	nits	Unit
					Min	Max	
Logic input section.			•				
Input high voltage	VINH		-55°C to +125°C	01	2.4		V
		VDD = 2.35 V			1.8		
Input low voltage	VINL	VDD = 3 V	-55°C to +125°C	01		0.4	V
		VDD = 5 V				0.8	
Input current, SCLK pin	lin	Typically 10 nA, VIN = 0 V or VDD	-55°C to +125°C	01		±1	μА
Input current, CS pin	lin		-55°C to +125°C	01	±1 ty	ypical	μА
Input capacitance	CIN	4/	-55°C to +125°C	01		10	pF
Logic output section.			1	l	l		
Output high voltage	Voн	ISOURCE = 200 μA, VDD = 2.35 V to 5.25 V	-55°C to +125°C	01	VDD - 0.2		V
Output low voltage	VoL	ISINK = 200 μA	-55°C to +125°C	01		0.4	V
Floating state leakage current			-55°C to +125°C	01		±10	μА
Floating state output capacitance		4/	-55°C to +125°C	01		10	pF
Output coding		Straight (natural) binary	-55°C to +125°C	01			
Conversion rate section.	•					1	
Conversion time		16 SCLK	-55°C to +125°C	01		1.33	μS
Track and hold		Full scale step input	-55°C to +125°C	01		500	ns
acquisition time		Sine wave input ≤ 100 kHz	1			400	1
Throughput rate			-55°C to +125°C	01		600	kSPS

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TABLE I. Electrical performance characteristics - continued. $\underline{1}/$

Test	Symbol	Conditions <u>2</u> /	Temperature,	Device type	Lir	nits	Unit
			.,,		Min	Max]
Power requirements sec	tion.						
Supply voltage	VDD		-55°C to +125°C	01	2.35	5.25	V
Supply current, normal mode (static)	IDD	Digital I/Ps = 0 V or VDD, VDD = 4.75 V to 5.25 V, SCLK on or off	-55°C to +125°C	01	2 ty	pical	mA
		Digital I/Ps = 0 V or VDD, VDD = 2.35 V to 3.6 V, SCLK on or off			1 ty	pical	
Supply current, normal mode (operational)	IDD	Digital I/Ps = 0 V or VDD, VDD = 4.75 V to 5.25 V, $fSAMPLE = fSAMPLE \max \underline{5}/$	-55°C to +125°C	01		3	mA
		Digital I/Ps = 0 V or VDD, VDD = 2.35 V to 3.6 V, fSAMPLE = fSAMPLE max 5				1.4	
Full power down mode	FPDM	SCLK off	-55°C to +125°C	01		1	μА
		SCLK on				80	
Power dissipation, normal mode (operational)	PD	VDD = 5 V, fSAMPLE = fSAMPLE max <u>5</u> /	-55°C to +125°C	01		15	mW
		VDD = 3 V, fSAMPLE = fSAMPLE max <u>5</u> /				4.2	
Power dissipation, full power down	PD	VDD = 5 V, SCLK off	-55°C to +125°C	01		5	μW
		VDD = 3 V, SCLK off				3	

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TABLE I. Electrical performance characteristics - continued. $\underline{1}/$

Test	Symbol	Conditions 6/7/	Temperature,	Device type	Lim	nits	Unit
			.,,		Min	Max	
Timing specifications sec	ction.		·				
Serial clock <u>8</u> / frequency	fSCLK	At 3 V	-55°C to +125°C	01	10		kHz
nequency	quericy	At 5 V			10		
		At 3 V				12	MHz
		At 5 V				12	
Conversion time	tCONVERT	At 3 V	-55°C to +125°C	01	16 x tSCLK		
		At 5 V			16 x tsclk		
Minimum quite time required between bus	tQUIET	At 3 V	-55°C to +125°C	01	50		ns
relinquish and start of next conversion		At 5 V			50		
Minimum CS pulse	t1	At 3 V	-55°C to +125°C	01	10		ns
width		At 5 V			10		
CS to SCLK setup	t2	At 3 V	-55°C to +125°C	01	10		ns
time		At 5 V			10		
Delay from CS 9/	t3	At 3 V	-55°C to +125°C	01	01	20	ns
until SDATA three state disabled		At 5 V		-		20	
Data access time 9/	t4	At 3 V	-55°C to +125°C	01		40	ns
after SCLK falling edge, A version		At 5 V				20	
Data access time <u>9/</u> after SCLK falling	t4	At 3 V	-55°C to +125°C	01		70	ns
edge, B version		At 5 V				20	

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TABLE I. Electrical performance characteristics - continued. 1/

Test	Symbol	Conditions 6/7/	Temperature,	Device type	Lin	nits	Unit
					Min	Max	
Timing specifications sec	tion - continued						
SCLK low pulse width	t5	At 3 V	-55°C to +125°C	01	0.4 x tsclk		ns
		At 5 V			0.4 x tSCLK		
SCLK high pulse width	t6	At 3 V	-55°C to +125°C	01	0.4 x tsclk		ns
		At 5 V			0.4 x tSCLK		
SCLK to data valid hold time	t7	At 3 V	-55°C to +125°C	01	10		ns
Hold time		At 5 V			10		
SCLK falling edge 10/ to SDATA high	t8	At 3 V	-55°C to +125°C	01	10	25	ns
impedance		At 5 V			10	25	
Power up time from	tPOWER-UP	At 3 V	-55°C to +125°C	01	1 typ	oical	ns
full power down		At 5 V			1 ty	oical	

- Testing and other quality control techniques are used to the extent deemed necessary to assure product performance over the specified temperature range. Product may not necessarily be tested across the full temperature range and all parameters may not necessarily be tested. In the absence of specific parametric testing, product performance is assured by characterization and/or design.
- 2/ Unless otherwise specified, VDD = 2.35 V to 5.25 V, fSCLK = 12 MHz, and fSAMPLE = 600 kSPS
- 3/ Specifications apply as typical figures when VDD = 5.25 V.
- 4/ Guaranteed by characterization.
- 5/ fsample max = 600 kSPS.
- 6/ 3 V specifications apply from VDD = 2.35 V to 3.6 V and 5 V specifications apply from VDD = 4.75 V to 5.25 V.
- $\overline{2}$ / Guaranteed by characterization. All input signals are specified with tr = tf = 5 ns (10% to 90% of VDD) and timed from a voltage level of 1.6 V.
- 8/ Mark/space ratio for the SCLK input is 40/60 to 60/40.
- 9/ Measured with the load circuit of figure 3 and defined as the time required for the output to cross 0.8 V to 2.0 V.
- 10/ ts is derived from the measured time taken by the data output to change 0.5 V when loaded with the circuit in figure 3. The measured number is then extrapolated to remove the effects of charging or discharging the 50 pF capacitor. This means that the time, ts, is the true bus relinquish time of the part and is independent of the bus loading.

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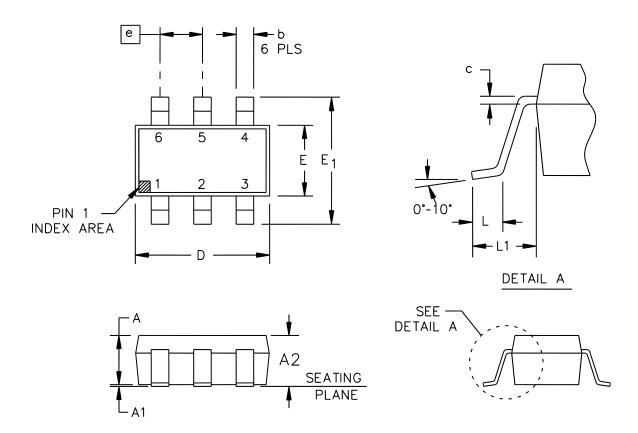


FIGURE 1. Case outline.

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	Dimensions				
Symbol	Inches		Millim	neters	
	Min	Max	Min	Max	
А	0.035	0.051	0.90	1.30	
A1	0.001	0.005	0.05	0.15	
A2	0.037	0.057	0.95	1.45	
b	0.011	0.019	0.30	0.50	
С	0.003	0.007	0.08	0.20	
D	0.110	0.118	2.80	3.00	
Е	0.059	0.069	1.50	1.70	
E1	0.102	0.118	2.60	3.00	
е	0.037 BSC		0.95	BSC	
L	0.013	0.021	0.35	0.55	
L1	0.023 BSC		0.60	BSC	

NOTES:

- Controlling dimensions are millimeter, inch dimensions are given for reference only.
 Falls within reference to JEDEC MO-178-AB.

FIGURE 1. Case outline - Continued.

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Device type		01
Case outline		Х
Terminal number	Terminal symbol	Description
1	VDD	Power supply input. The VDD range for the device is from 2.35 V to 5.25 V.
2	GND	Analog ground. Ground reference point for all circuitry on the part. All analog input signals should be referred to this GND voltage.
3	VIN	Analog input. Single ended analog input channel. The input range is 0 V to VDD.
4	SCLK	Serial clock. Logic input. SCLK provides the serial clock for accessing data from the part. This clock input is also used as the clock source for the device conversion process.
5	SDATA	Data out. Logic output. The conversion result is provided on this output as serial data stream. The bits are clocked out on the falling edge of the SCLK input. The data stream from the device consists of four leading zeros followed by the 12 bits of conversion data; this is provided MSB first.
6	ĊS	Chip select. Active low logic input. This input provides the dual function of initiating conversions on the device and framing the serial data transfer.

FIGURE 2. <u>Terminal connections</u>.

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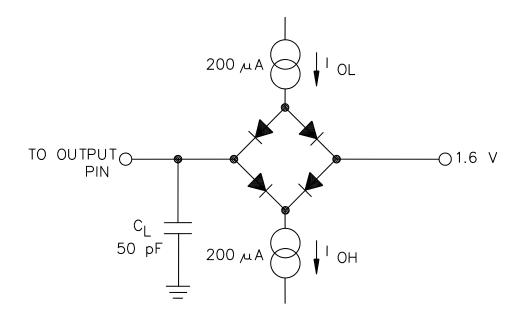


FIGURE 3. Load circuit for digital output timing specifications.

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4. VERIFICATION

4.1 <u>Product assurance requirements</u>. The manufacturer is responsible for performing all inspection and test requirements as indicated in their internal documentation. Such procedures should include proper handling of electrostatic sensitive devices, classification, packaging, and labeling of moisture sensitive devices, as applicable.

5. PREPARATION FOR DELIVERY

- 5.1 <u>Packaging</u>. Preservation, packaging, labeling, and marking shall be in accordance with the manufacturer's standard commercial practices for electrostatic discharge sensitive devices.
 - 6. NOTES
 - 6.1 ESDS. Devices are electrostatic discharge sensitive and are classified as ESDS class 1 minimum.
- 6.2 <u>Configuration control</u>. The data contained herein is based on the salient characteristics of the device manufacturer's data book. The device manufacturer reserves the right to make changes without notice. This drawing will be modified as changes are provided.
- 6.3 <u>Suggested source(s) of supply</u>. Identification of the suggested source(s) of supply herein is not to be construed as a guarantee of present or continued availability as a source of supply for the item. DLA Land and Maritime maintains an online database of all current sources of supply at https://landandmaritimeapps.dla.mil/Programs/Smcr/.

Vendor item drawing administrative control number <u>1</u> /	Device manufacturer CAGE code	Linearity error (LSB) 2/	Vendor part number
V62/11611-01XE	24355	±1.5 maximum	AD7476SRTZ-EP-RL7

- 1/ The vendor item drawing establishes an administrative control number for identifying the item on the engineering documentation.
- 2/ Linearity error refers to integral linearity error.

<u>CAGE code</u> <u>Source of supply</u>

24355 Analog Devices

Route 1 Industrial Park P.O. Box 9106 Norwood, MA 02062

Point of contact: Raheen Business Park

Limerick, Ireland

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